

SPECIFICATION

E0900068 V1

Rev. Group Drawing No

of 7 Sheet 1

				1	APPROVALS	S
AUTHOR:	CHECKED:	DATE	-	DCN NO.	REV	DATE
R. Dannenberg	G. Billingsley	3/20/	09		_	
					_	
						-
Nome						
		End Test Mass (ETM)				
Applicable Docume	nts					
Blank Specification		E080047				
Blank Drawing		D080055				
Polish Specification		E080512-v2				
Polish Drawing		D080658-A				
Coating Specification		E0900068-v1				
8 . 1						
Fabricate From		D080055				
		2000000				
Surface Ouelity						
Surface Quality						
(Scratch 1 otal Area	l) . 1 in aide 120anna					
Max Scratches Surface	e 1 inside 120mm					
$(units of um^2)$		20000				
		20000				
Max Scratches Surface	e 1 outside 120mm					
to 160 mm diameter (1000 m^2)		500000				
(UIIIIS OF UM) May Scratches Surface 2 inside 120mm		300000				
diameter	z 2 mside 120mm					
(units of um^2)		1000000				
, ,						
Surface Quality						
(Total Defect Number)						
Max Point Defects Surface 1 inside		10				
120mm diameter		10				

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Max Point Defect Density Surface 1 inside 120 mm diameter	1 per 4 mm ²
Max Point Defects Surface 1 outside 120 mm to 160 mm diameter	100
Max Point Defects Surface 2 inside 120 mm diameter	100
General to All Surfaces	
Coating Thickness Uniformity	Fractional Change <0.001 over 160 mm diameter. If the physical thickness variation of the coating cannot be measured with a profilometer or inferred interferometrically, it may be inferred from the wavelength shift of the coating as a function of position
Coating Relative Wavelength Uniformity	Fractional Change <0.001 over 160 mm diameter
Coating Area	To Bevel
	Once Witness Piece Per Run:
	Coating to resist adhesion test per MIL-C-48497A 4.5.3.1 Adhesion (snap tape). MIL-C-4.5.3.2 Humidity (120F 95% RH for 24 hours), combined with before/after spectrophotometer scan from 400 - 2500 nm,
	scanned. There should be no measureable spectral shift.
Witness Sample Durability Testing	MIL-C-4.5.3.3 Moderate Abrasion (cheesecloth rub).
Surface 1	NOTE: ARROWS ON OPTIC SIDE POINT TO SURFACE 1
Coating Type	High Reflection

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Angle of Incidence	Normal		
Transmission at 1064 nm	< 6 ppm requirement		
Transmission Matching Rotwoon Parts at			
1064 nm	N/A		
Transmission at 532 nm	0.01 - 0.15, goal of 0.05		
	2 (T1-T2)/(T1+T2) < 0.1 for T1=25 °C to		
Thermal Stability at 532 nm			
Thermal Stability at 1064 nm	3 (11-12)/(11+12) < 0.01 for $11=25$ °C to T2=40 °C		
	The coating is comprised of silicon-dioxide layers		
	alternating with layers tantalum pentoxide doped		
Coating Materials	with 25% (by cation) titanium dioxide.		
	E<0.01 V/m. Vendor must demonstrate through		
	calculation using E [V/m] = 27.46 (T / Re (Y)) ^{0.5}		
Course of Florestic Field 10/4	with T being the transmittance and Y the		
Surface Electric Field 1064 nm	admittance in tree space units		





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	$< 4.1 \ 10^{-21} \text{ m/}\sqrt{\text{Hz}}$ at 100 Hz – This is to be
	calculated from the material layer thicknesses,
	other parameters provided by LIGO, and by a
	formula provided by LIGO. The requirement is
	that using the provided formula, the predicted
	thermal noise should be below this level, the goal
	is to get as low a thermal noise as possible. This is
	to be done on a best-effort basis with no warranty
Thomas Noise	or guarantee of suitability of use for any
	application
Surface 2	
Coating Type	Antireflection
Angle of Incidence	Normal
Reflection at 1064 nm	< 500 ppm requirement
Reflection at 1064 nmReflection at 532 nm	<pre>< 500 ppm requirement < 100 pm requirement</pre>
Reflection at 1064 nmReflection at 532 nmSurface Electric Field	< 500 ppm requirement < 100 pm requirement N/A
Reflection at 1064 nmReflection at 532 nmSurface Electric FieldScatter	<pre>< 500 ppm requirement </pre> < 100 pm requirement N/A N/A
Reflection at 1064 nm Reflection at 532 nm Surface Electric Field Scatter	<pre>< 500 ppm requirement < 100 pm requirement N/A N/A</pre>
Reflection at 1064 nmReflection at 532 nmSurface Electric FieldScatterAbsorption	<pre>< 500 ppm requirement < 100 pm requirement N/A N/A <1 ppm requirement.</pre>
Reflection at 1064 nmReflection at 532 nmSurface Electric FieldScatterAbsorptionThermal Stability at 532 nm	<pre>< 500 ppm requirement < 100 pm requirement N/A N/A </pre>
Reflection at 1064 nmReflection at 532 nmSurface Electric FieldScatterAbsorptionThermal Stability at 532 nmThermal Stability at 1064 nm	< 500 ppm requirement < 100 pm requirement N/A N/A
Reflection at 1064 nmReflection at 532 nmSurface Electric FieldScatterAbsorptionThermal Stability at 532 nmThermal Stability at 1064 nmCoating Materials	< 500 ppm requirement < 100 pm requirement N/A N/A <a href="https://www.selecture.com/selecture.c</th></tr><tr><th>Reflection at 1064 nmReflection at 532 nmSurface Electric FieldScatterAbsorptionThermal Stability at 532 nmThermal Stability at 1064 nmCoating Materials</th><th> < 500 ppm requirement < 100 pm requirement N/A N/A <1 ppm requirement. N/A N/A N/A N/A </th></tr><tr><th>Reflection at 1064 nmReflection at 532 nmSurface Electric FieldScatterAbsorptionThermal Stability at 532 nmThermal Stability at 1064 nmCoating MaterialsOther</th><th>< 500 ppm requirement</p> < 100 pm requirement</p> N/A <p</th></tr><tr><th>Reflection at 1064 nm Reflection at 532 nm Surface Electric Field Scatter Absorption Thermal Stability at 532 nm Thermal Stability at 1064 nm Coating Materials Other</th><th>< 500 ppm requirement</p> < 100 pm requirement</p> N/A <p</th></tr><tr><th>Reflection at 1064 nm Reflection at 532 nm Surface Electric Field Scatter Absorption Thermal Stability at 532 nm Thermal Stability at 1064 nm Coating Materials Other</th><th>< 500 ppm requirement</p> < 100 pm requirement</td> N/A N/A <1 ppm requirement.</td> N/A N/A N/A N/A N/A N/A N/A N/A N/A</th></tr><tr><th>Reflection at 1064 nmReflection at 532 nmSurface Electric FieldScatterAbsorptionThermal Stability at 532 nmThermal Stability at 1064 nmCoating MaterialsOtherAdditional Deliverables</th><th>< 500 ppm requirement</p> < 100 pm requirement</td> N/A N/A <1 ppm requirement.</td> N/A N/A N/A N/A</th></tr><tr><th>Reflection at 1064 nm Reflection at 532 nm Surface Electric Field Scatter Absorption Thermal Stability at 532 nm Thermal Stability at 1064 nm Coating Materials Other Additional Deliverables</th><th> < 500 ppm requirement < 100 pm requirement N/A N/A N/A N/A Ten 1-inch witness samples, provided by LIGO,



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2. Measured and Design Layer Thicknesses	For all layers in the design, measured thickness data from the deposition for each run), designed thicknesses, and measured indices of refraction at both 1064 nm and 532 nm for both coating materials (based on individual layers).
3. Surface 1 Spectrophotometer Scans	On a representative witness piece for each run, spectrophotometer graphs of reflectance and transmission of Surface 1 (HR coating) from 350- 2500 nm before it is coated, between Surface 1 and Surface 2 coating, and after coating is completed. LIGO's preference is to have all spectrophotometer data be provided in Excel spreadsheet format.
4. Surface 2 Spectrophotometer Scans	On a representative witness piece for each run, spectrophotometer graph of reflectance of Surface 2 (AR coating) from 350-2500 nm before it is coated, between Surface 1 and Surface 2 coating, and after coating is completed. LIGO's preference is to have all spectrophotometer data be provided in Excel spreadsheet format.
5. Scatter Maps.	Maps of scatter, absorption, and transmission over central 160 mm diameter with optic orientation specified. Scatter should be measured accurately to ± 1 ppm, absorption to ± 0.1 ppm, and transmission to ± 0.001 .



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	METHOD 1.
	The surface is examined visually by two observers independently. The examination is done against a dark background using a fiber optic illumination system of at least 200 W total power. A 100% inspection of the surface is carried out. Pits and scratches down to 2 micrometers in width can be detected using this method of inspection. Any scratches or sleeks that are detected will be measured using a calibrated eyepiece.
6. Scratches & Point Defects Methods 1&2 (Hand Sketch).	METHOD 2. Further inspection will be done with a minimum 6X eyeglass using the same illumination conditions, again with two observers. Sleeks down to 0.5 micrometers wide can be detected using this method. The surface will be scanned along one or two chords from centre to edge, then at ten positions around the edge, and ten to fifteen positions near the centre.
	METHOD 3.
	An inspection is then carried out with a dark or bright field microscope, with 5x objective at four positions at each of the following locations:a) Within 10mm of the center of the surface.
	b) Equally spaced along the circumference of a centered, 60 mm diameter circle.
7. Scratches & Point Defects Method 3 (Digital Images).	c) Equally spaced along the circumference of a centered, 120 mm diameter circle.
8. Durability Test Data & Samples.	All samples from the durability tests and data, including spectrophotometer scans of the representative coating on each side in an Excel spreadsheet.



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